## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | DRESTI ET AL. Examiner | Art Unit | Son P. Huynh | 2623 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,597,374	07-2003	Baker et al.	715/717
*	В	US-7,174,512	02-2007	Martin et al.	715/719
*	С	US-6,124,804	09-2000	Kitao et al.	340/825.69
*	D	US-6,157,319	12-2000	Johns et al.	340/825.72
*	Е	US-2002/0126035	09-2002	Hou, Shaw-Yuan	341/176
*	F	US-2002/0140885	10-2002	Ueno, Takashi	349/113
*	G	US-6,008,735	12-1999	Chiloyan et al.	340/825.22
	Н	US-			
	1	US-			
	7	US-			
	Κ	US-			
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	×						
	x						

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